Dual N-Channel 30 V (D-S) MOSFETs

PRODUCT SUMMARY				
	V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A)[a]	Q_g (Typ.)
Channel-1	30	0.0200 at V_{GS} = 10 V	11	3.5 nC
		0.0265 at V_{GS} = 4.5 V	11	
Channel-2	30	0.0090 at V_{GS} = 10 V	28	6.8 nC
		0.0135 at V_{GS} = 4.5 V	28	

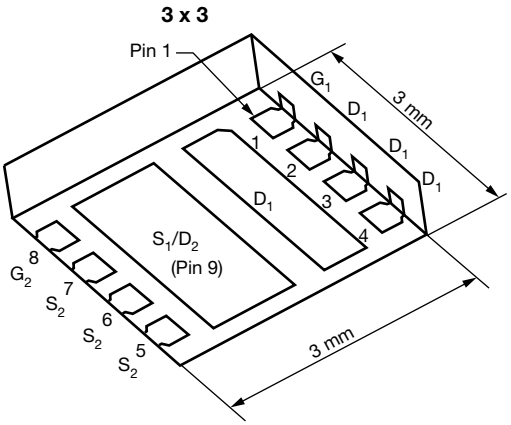
FEATURES

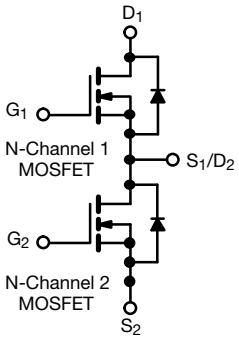
- DFN Optimizes High-Side and Low-Side MOSFETs for Synchronous Buck Converters
- Trench Power Mosfets
- 100 % R_g and UIS Tested
-

RoHS COMPLIANT
HALOGEN FREE

APPLICATIONS

- Computing System Power
- POL
- Synchronous Buck Converter





ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C, unless otherwise noted)					
Parameter		Symbol	Channel-1	Channel-2	Unit
Drain-Source Voltage		V_{DS}	30		V
Gate-Source Voltage		V_{GS}	± 20		
Continuous Drain Current (T_J = 150 °C)	T_C = 25 °C	I_D	11[a]	28[a]	A
	T_C = 70 °C		11[a]	28[a]	
	T_A = 25 °C		9.8[b, c]	14.9[b, c]	
	T_A = 70 °C		7.8[b, c]	11.9[b, c]	
Pulsed Drain Current (t = 300 µs)		I_{DM}	30	40	
Continuous Source Drain Diode Current	T_A = 25 °C	IS	11[a]	26	
	T_A = 25 °C		3.2[b, c]	3.8[b, c]	
Avalanche Current	L = 0.1 mH	I_{AS}	12	15	
Single Pulse Avalanche Energy		E_{AS}	7	11	mJ
Maximum Power Dissipation	T_C = 25 °C	P_D	16.7	31	W
	T_C = 70 °C		10.7	20	
	T_A = 25 °C		3.7[b, c]	4.2[b, c]	
	T_A = 70 °C		2.4[b, c]	2.7[b, c]	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	- 55 to 150		°C
Soldering Recommendations (Peak Temperature)[d, e]			260		

Notes:
a. Package limited.
b. Surface mounted on 1" x 1" FR4 board.
c. t = 10 s.
d. The PowerPAIR is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

THERMAL RESISTANCE RATINGS

Parameter		Symbol	Channel-1 Typ.	Channel-1 Max.	Channel-2 Typ.	Channel-2 Max.	Unit
Maximum Junction-to-Ambient[a, b]	t ≤ 10 s	R_{thJA}	27	34	24	30	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	6	7.5	3.2	4	

Notes:
a. Surface mounted on 1" x 1" FR4 board.
b. Maximum under steady state conditions is 69 °C/W for channel-1 and 64 °C/W for channel-2.

SPECIFICATIONS (T_J = 25 °C, unless otherwise noted)

Parameter	Symbol	Test Conditions		Min.	Typ.	Max.	Unit
Static							
Drain-Source Breakdown Voltage	V_{DS}	V_{GS} = 0, I_D = 250 µA	Ch-1	30			V
		V_{GS} = 0 V, I_D = 250 µA	Ch-2	30			
V_{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	I_D = 250 µA	Ch-1		24		mV/°C
		I_D = 250 µA	Ch-2		30		
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I_D = 250 µA	Ch-1		- 4.1		
		I_D = 250 µA	Ch-2		- 5		
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS} = V_{GS}, I_D = 250 µA	Ch-1	1		2.4	V
		V_{DS} = V_{GS}, I_D = 250 µA	Ch-2	1		2.2	
Gate Source Leakage	I_{GSS}	V_{DS} = 0 V, V_{GS} = ± 20 V	Ch-1			± 100	nA
			Ch-2			± 100	
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 30 V, V_{GS} = 0 V	Ch-1			1	µA
		V_{DS} = 30 V, V_{GS} = 0 V	Ch-2			1	
		V_{DS} = 30 V, V_{GS} = 0 V, T_J = 55 °C	Ch-1			5	
		V_{DS} = 30 V, V_{GS} = 0 V, T_J = 55 °C	Ch-2			5	
On-State Drain Current[b]	$I_{D(on)}$	V_{DS} ≥ 5 V, V_{GS} = 10 V	Ch-1	10			A
		V_{DS} ≥ 5 V, V_{GS} = 10 V	Ch-2	10			
Drain-Source On-State Resistance[b]	$R_{DS(on)}$	V_{GS} = 10 V, I_D = 9.8 A	Ch-1		0.0200		Ω
		V_{GS} = 10 V, I_D = 15 A	Ch-2		0.0090		
		V_{GS} = 4.5 V, I_D = 8.5 A	Ch-1		0.0265		
		V_{GS} = 4.5 V, I_D = 12 A	Ch-2		0.0135		
Forward Transconductance[b]	g_{fs}	V_{DS} = 15 V, I_D = 9.8 A	Ch-1		30		S
		V_{DS} = 15 V, I_D = 15 A	Ch-2		30		
Dynamic[a]							
Input Capacitance	C_{iss}	Channel-1 V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz	Ch-1		400		pF
			Ch-2		730		
Output Capacitance	C_{oss}		Ch-1		125		
		Channel-2 V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz	Ch-2		155		
Reverse Transfer Capacitance	C_{rss}		Ch-1		25		
			Ch-2		65		
Total Gate Charge	Q_g	V_{DS} = 15 V, V_{GS} = 10 V, I_D = 9.8 A	Ch-1		7.4	12	nC
		V_{DS} = 15 V, V_{GS} = 10 V, I_D = 15 A	Ch-2		14.2	22	
		Channel-1 V_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 9.8 A	Ch-1		3.5	5.3	
			Ch-2		6.8	11	
Gate-Source Charge	Q_{gs}		Ch-1		1.5		
		Channel-2 V_{DS} = 15 V, V_{GS} = 4.5 V, I_D = 15 A	Ch-2		2.2		
Gate-Drain Charge	Q_{gd}		Ch-1		1.1		
			Ch-2		2.3		
Gate Resistance	R_g	f = 1 MHz	Ch-1	0.5	2.6	5.2	Ω
			Ch-2	0.5	2.6	5.2	

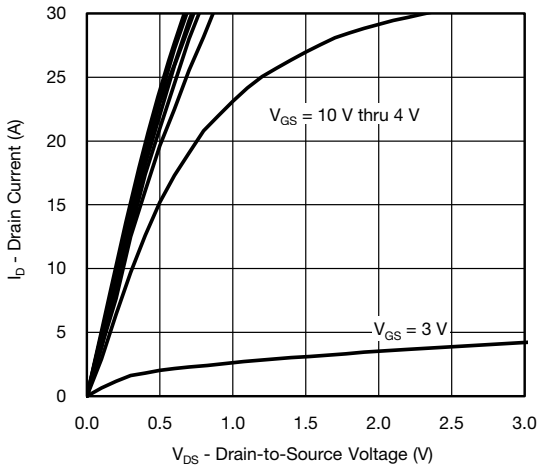
Notes:
a. Guaranteed by design, not subject to production testing.
b. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.

SPECIFICATIONS (T_J = 25 °C, unless otherwise noted)							
Parameter	**Symbol**	**Test Conditions**		**Min.**	**Typ.**	**Max.**	**Unit**
Dynamic[a]							
Turn-On Delay Time	$t_{d(on)}$	Channel-1 V_{DD} = 15 V, R_L = 1.9 Ω $I_D \cong$ 8 A, V_{GEN} = 4.5 V, R_g = 1 Ω Channel-2 V_{DD} = 15 V, R_L = 1.5 Ω $I_D \cong$ 10 A, V_{GEN} = 4.5 V, R_g = 1 Ω	Ch-1		25	50	ns
			Ch-2		25	50	
Rise Time	t_r		Ch-1		45	90	
			Ch-2		80	160	
Turn-Off Delay Time	$t_{d(off)}$		Ch-1		10	20	
			Ch-2		20	40	
Fall Time	t_f		Ch-1		10	20	
			Ch-2		40	80	
Turn-On Delay Time	$t_{d(on)}$	Channel-1 V_{DD} = 15 V, R_L = 1.9 Ω $I_D \cong$ 8 A, V_{GEN} = 10 V, R_g = 1 Ω Channel-2 V_{DD} = 15 V, R_L = 1.5 Ω $I_D \cong$ 10 A, V_{GEN} = 10 V, R_g = 1 Ω	Ch-1		5	10	
			Ch-2		5	10	
Rise Time	t_r		Ch-1		10	20	
			Ch-2		20	40	
Turn-Off Delay Time	$t_{d(off)}$		Ch-1		10	20	
			Ch-2		15	30	
Fall Time	t_f		Ch-1		7	15	
			Ch-2		10	20	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I_S	T_C = 25 °C	Ch-1			11	A
			Ch-2			26	
Pulse Diode Forward Current[a]	I_{SM}		Ch-1			30	
			Ch-2			40	
Body Diode Voltage	V_{SD}	I_S = 8 A, V_{GS} = 0 V	Ch-1		0.84	1.2	V
		I_S = 10 A, V_{GS} = 0 V	Ch-2		0.82	1.2	
Body Diode Reverse Recovery Time	t_{rr}	Channel-1 I_F = 8 A, dI/dt = 100 A/µs, T_J = 25 °C Channel-2 I_F = 10 A, dI/dt = 100 A/µs, T_J = 25 °C	Ch-1		17	35	ns
			Ch-2		20	40	
Body Diode Reverse Recovery Charge	Q_{rr}		Ch-1		9	20	nC
			Ch-2		14	30	
Reverse Recovery Fall Time	t_a		Ch-1		9.5		ns
			Ch-2		12.5		
Reverse Recovery Rise Time	t_b		Ch-1		7.5		
			Ch-2		7.5		

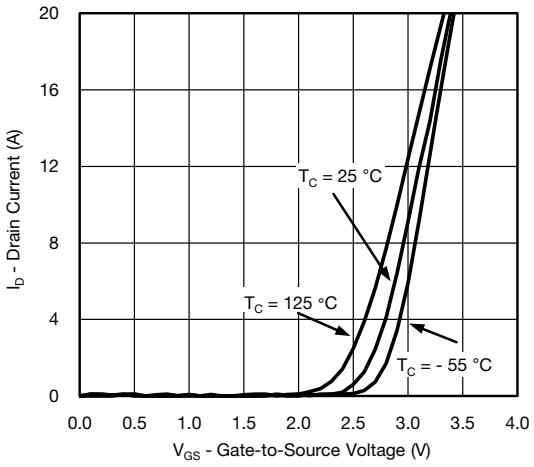
Notes:
a. Guaranteed by design, not subject to production testing.
b. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2 %.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

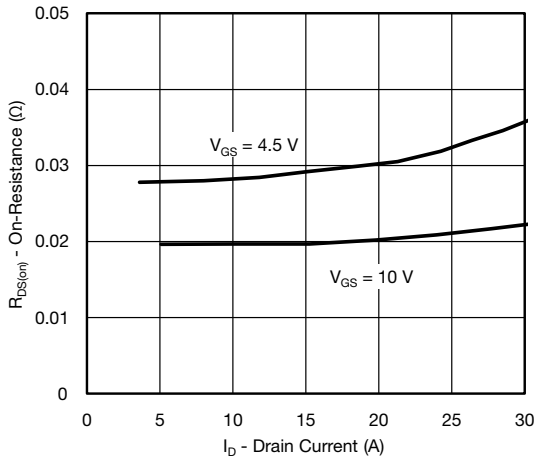
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



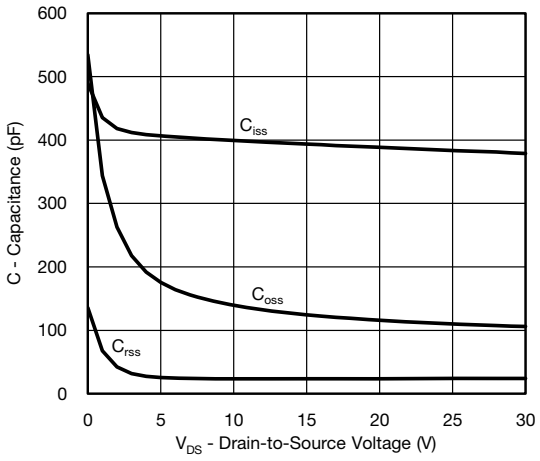
Output Characteristics



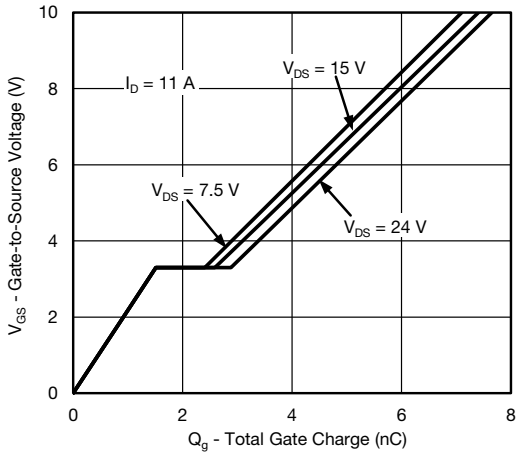
Transfer Characteristics



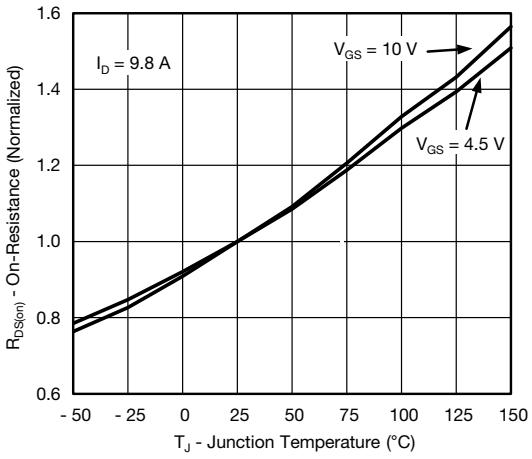
On-Resistance vs. Drain Current



Capacitance

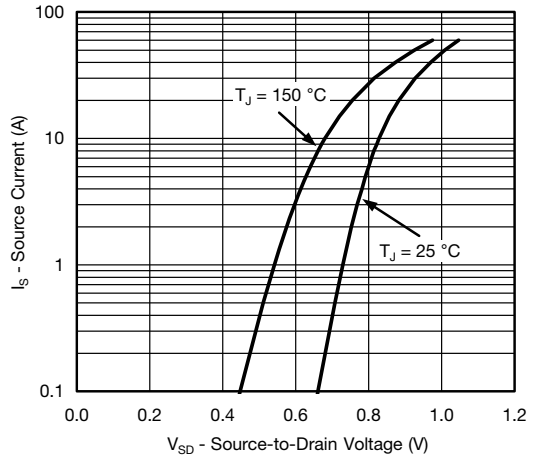


Gate Charge

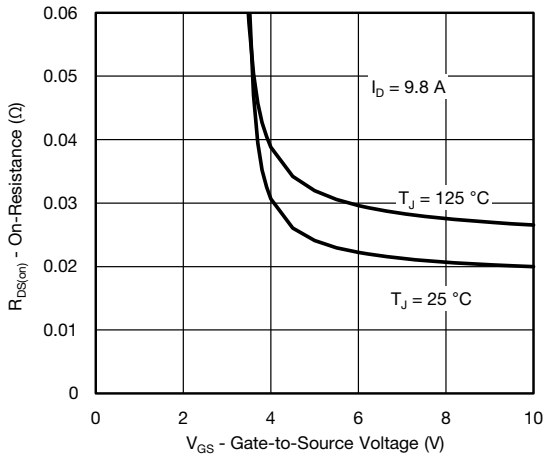


On-Resistance vs. Junction Temperature

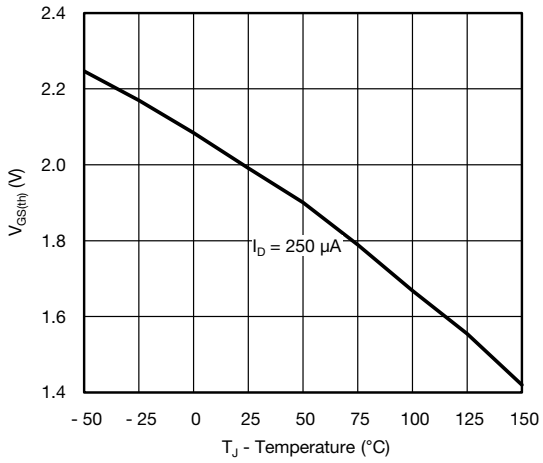
CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



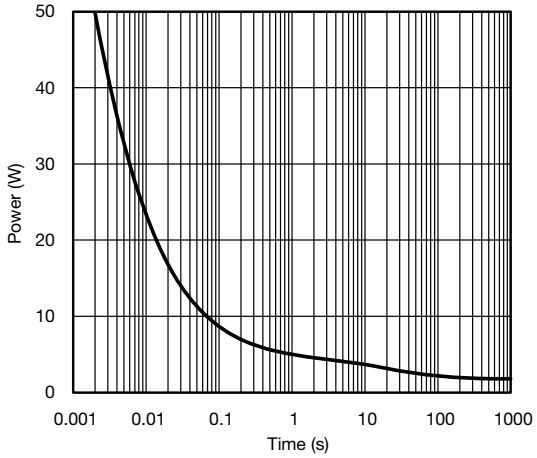
Source-Drain Diode Forward Voltage



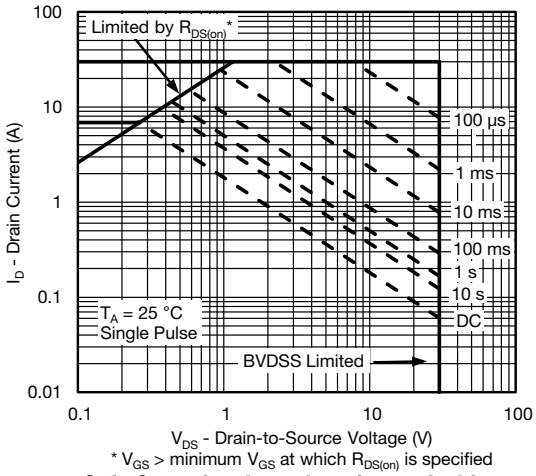
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



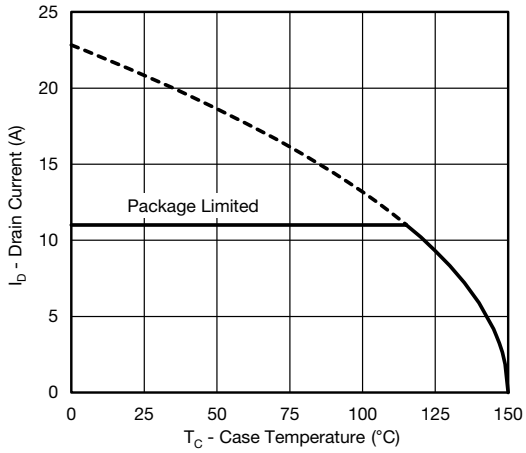
Single Pulse Power



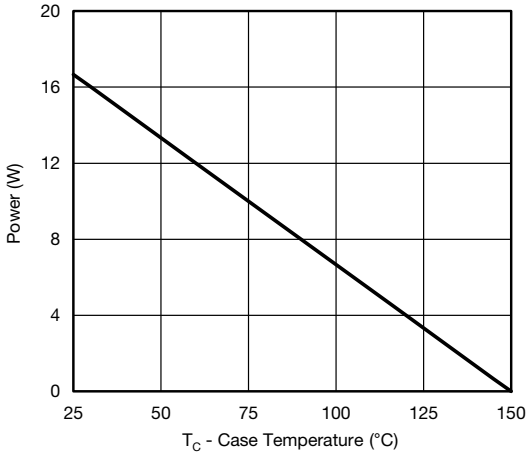
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



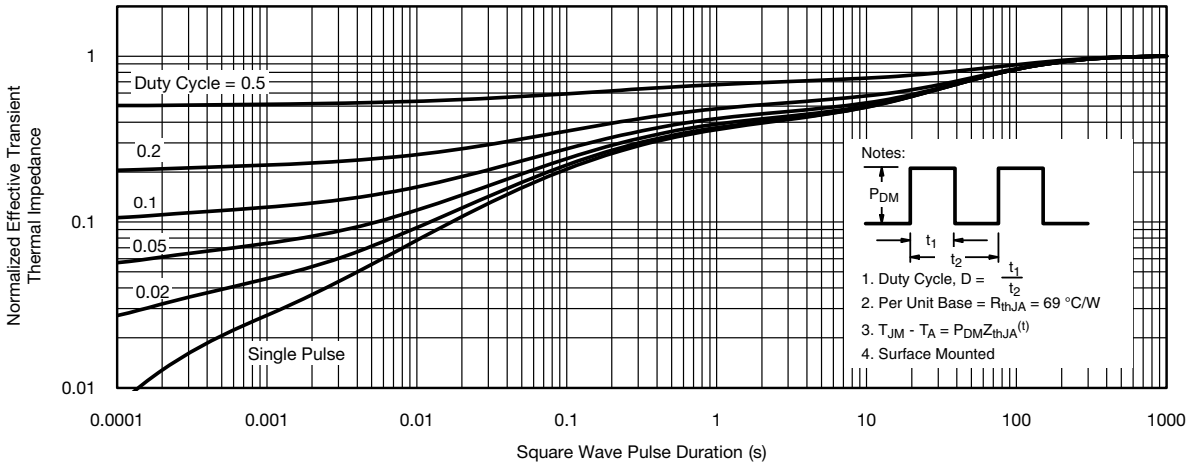
Current Derating*



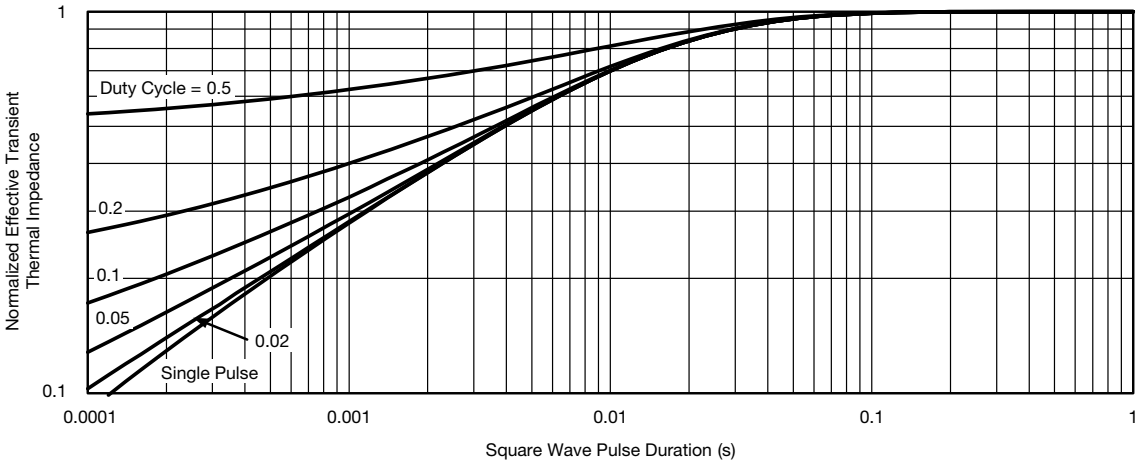
Power, Junction-to-Case

* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

CHANNEL-1 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

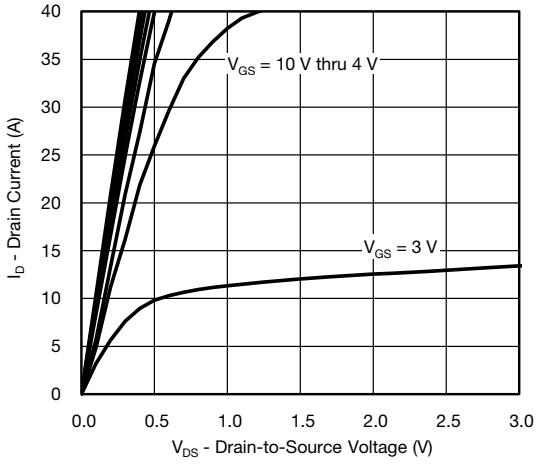


Normalized Thermal Transient Impedance, Junction-to-Ambient

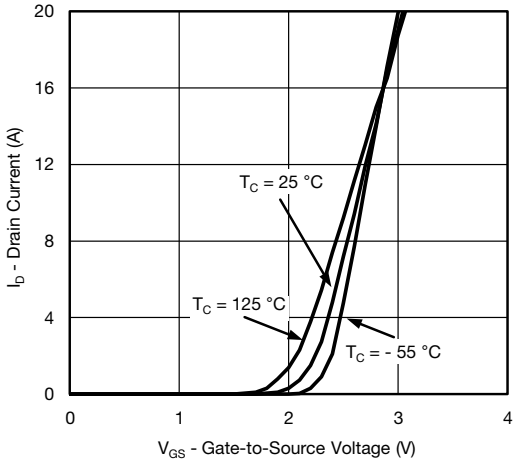


Normalized Thermal Transient Impedance, Junction-to-Case

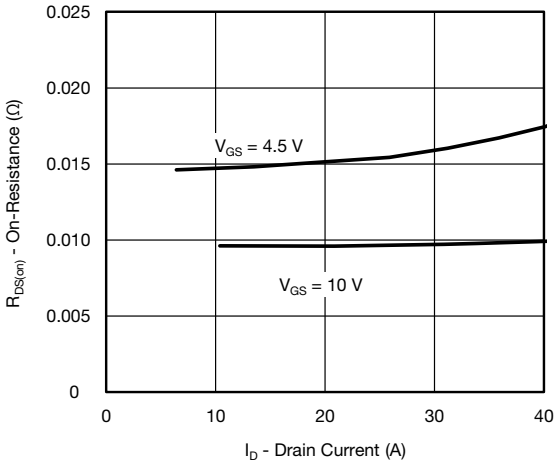
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



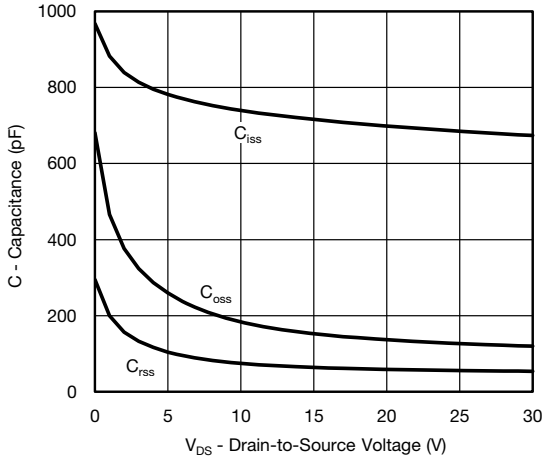
Output Characteristics



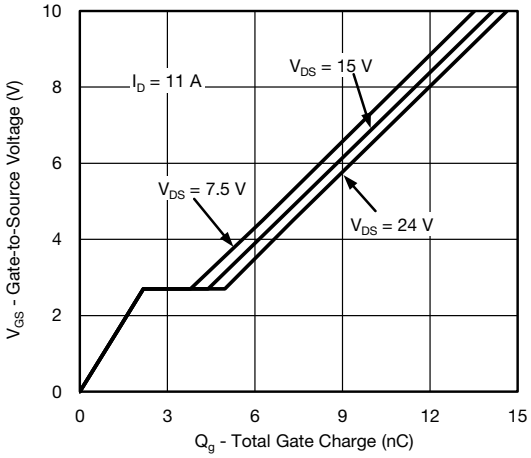
Transfer Characteristics



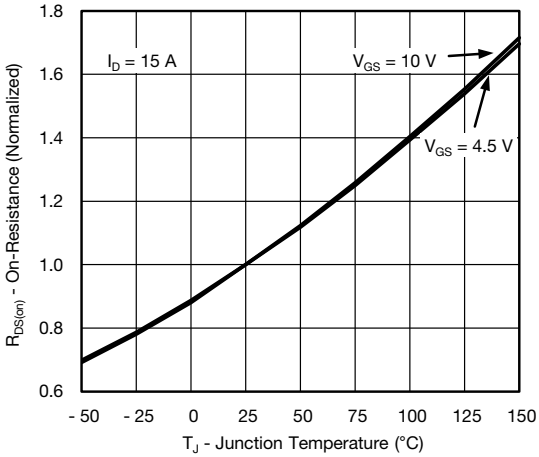
On-Resistance vs. Drain Current



Capacitance

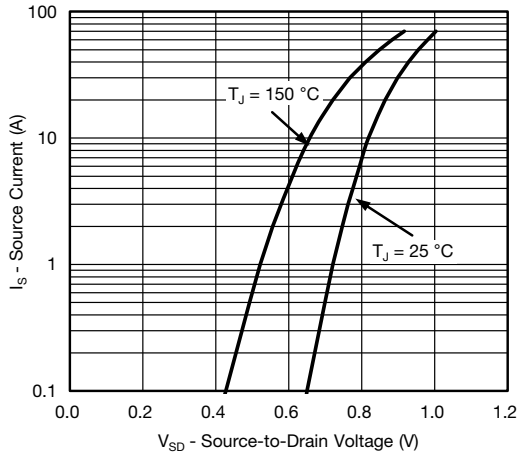


Gate Charge

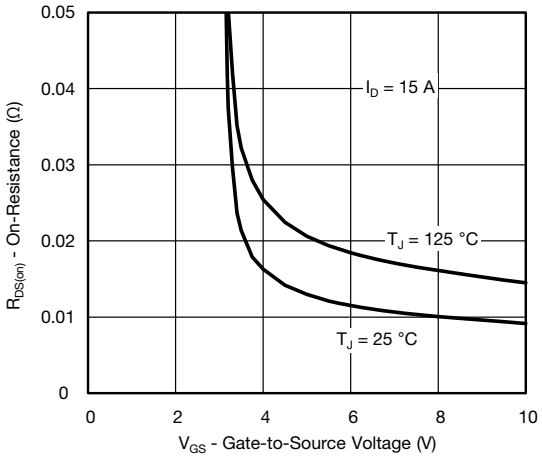


On-Resistance vs. Junction Temperature

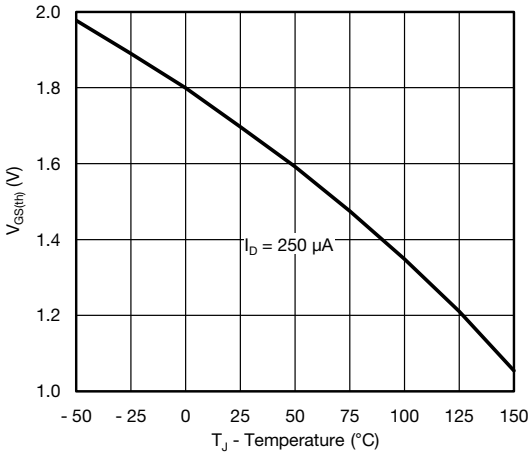
CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



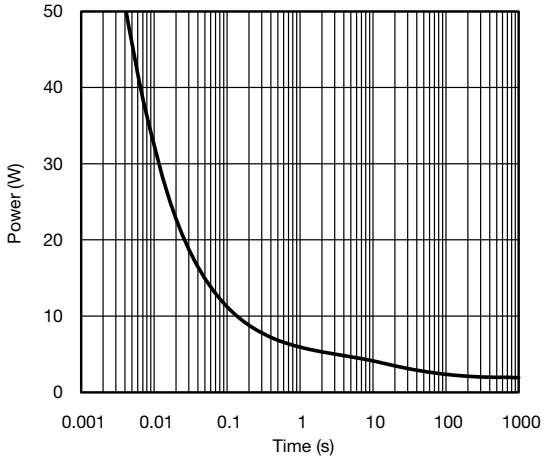
Source-Drain Diode Forward Voltage



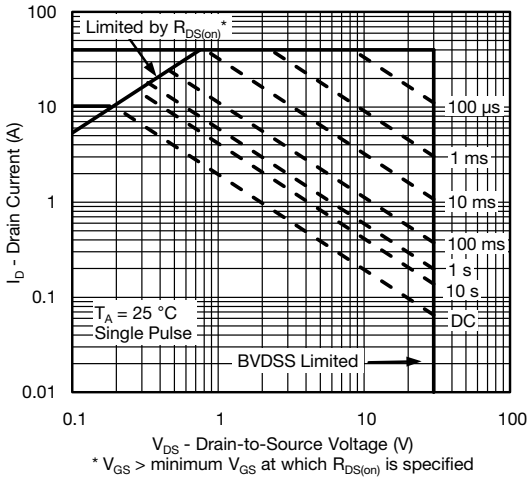
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

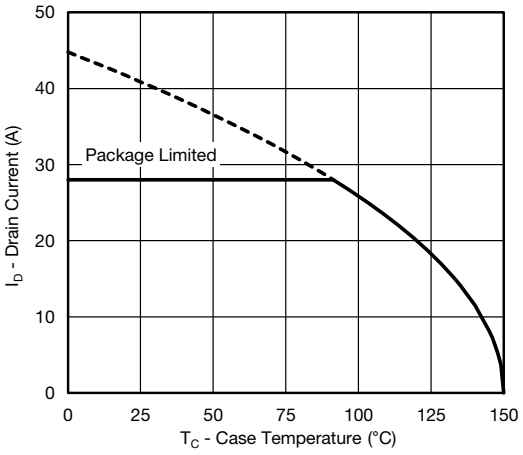


Single Pulse Power

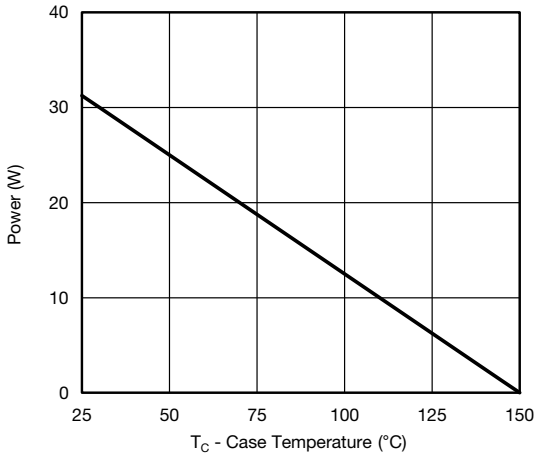


Safe Operating Area, Junction-to-Ambient

CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



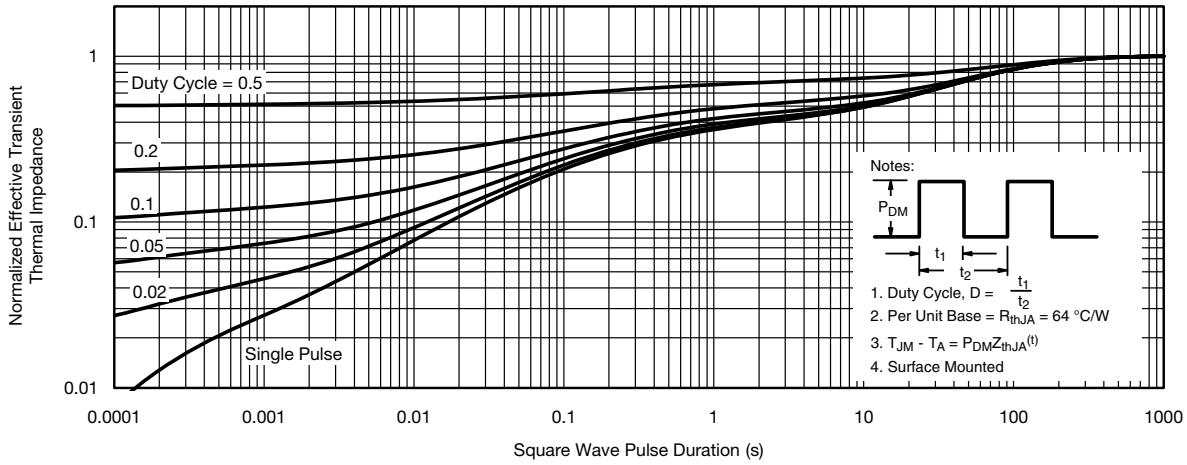
Current Derating*



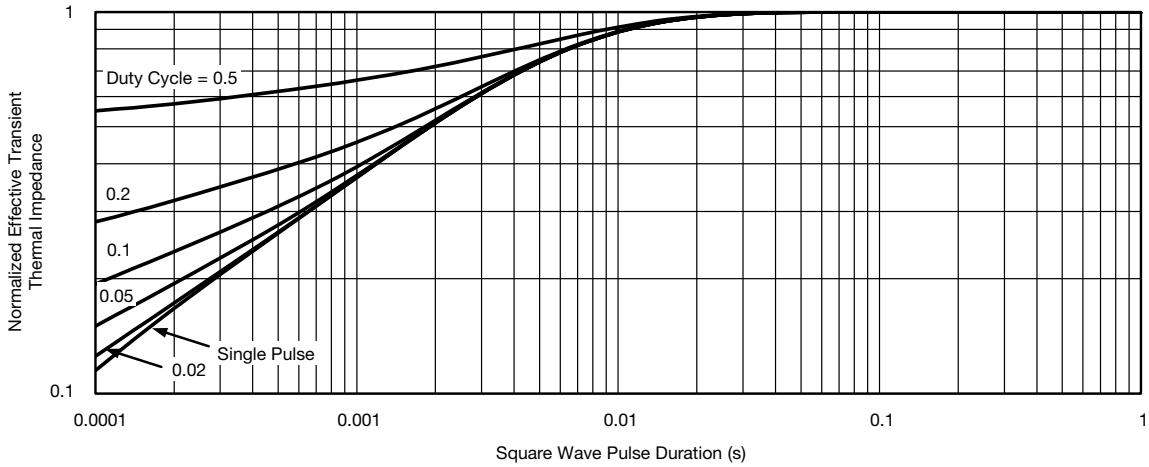
Power, Junction-to-Case

* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

CHANNEL-2 TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

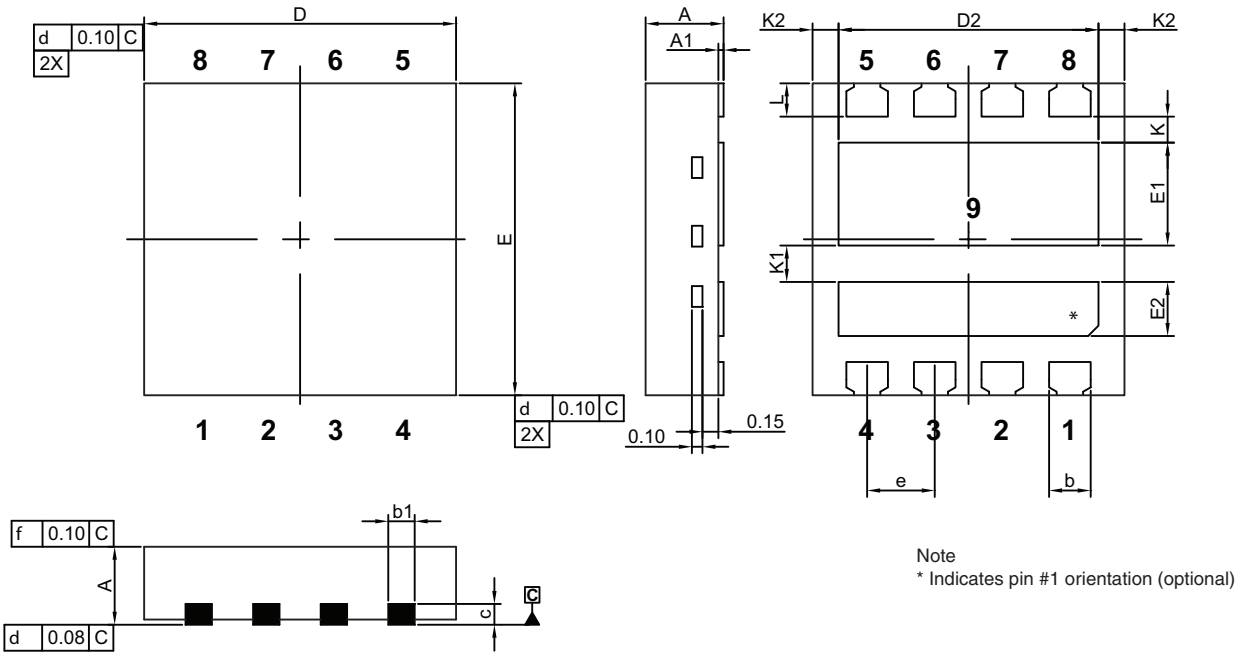


Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

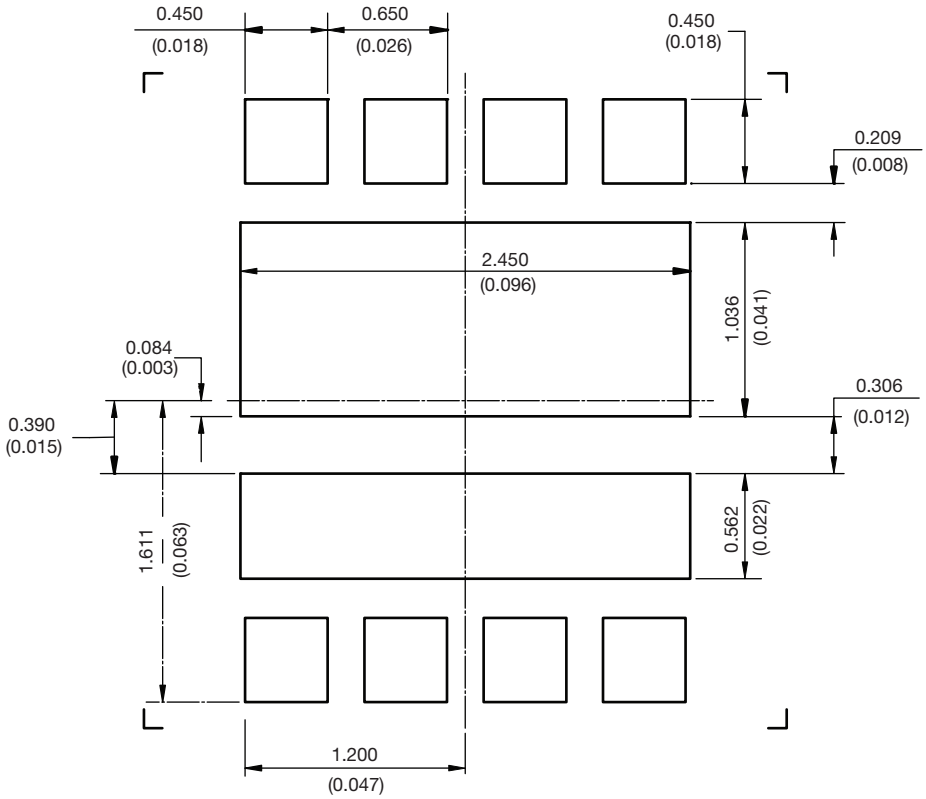
PowerPAIR® 3 x 3 Case Outline



Note
* Indicates pin #1 orientation (optional)

DIM.	MILLIMETERS			INCHES		
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.
A	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.35	0.40	0.45	0.014	0.016	0.018
b1	0.20	0.25	0.38	0.008	0.010	0.015
C	0.18	0.20	0.23	0.007	0.008	0.009
D	2.90	3.00	3.10	0.114	0.118	0.122
D2	2.35	2.40	2.45	0.093	0.094	0.096
E	2.90	3.00	3.10	0.114	0.118	0.122
E1	0.94	0.99	1.04	0.037	0.039	0.041
E2	0.47	0.52	0.57	0.019	0.020	0.022
e	0.65 BSC			0.026 BSC		
K	0.25 typ.			0.010 typ.		
K1	0.35 typ.			0.014 typ.		
K2	0.30 typ.			0.012 typ.		
L	0.27	0.32	0.37	0.011	0.013	0.015
ECN: T12-0347-Rev. C, 18-Jun-12 DWG: 5998						

RECOMMENDED MINIMUM PAD FOR PowerPAIR® 3 x 3



Recommended PAD for PowerPAIR 3 x 3

Dimensions in millimeters (inches)

Keep-Out 3.5 mm x 3.5 mm for non terminating traces

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